

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10517731	CHAPEL ET AL.
	Examiner	Art Unit
	Rutkowski, Jeffrey M	2609

SEARCHED

Class	Subclass	Date	Examiner
370	389	08/14/2007	JMR

SEARCH NOTES

Search Notes	Date	Examiner
See attached search notes	08/14/2007	JMR

INTERFERENCE SEARCH

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